Notice of References Cited Application/Control No. 10/714,291 Examiner Duc M. Nguyen Applicant(s)/Patent Under Reexamination HINTERMEIER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,961,579 B2	11-2005	Inukai et al.	455/456.4
*	В	US-6,085,096 A	07-2000	Nakamura, Noriyasu	455/456.6
*	С	US-6,718,175 B1	04-2004	Edstam, Anders Daniel	455/456.5
*	D	US-5,991,614 A	11-1999	Oura, Hideto	455/404.1
*	E	US-6,448,906 B1	09-2002	Nachtsheim et al.	340/945
*	F	US-6,108,563 A	08-2000	Shishino, Shinichi	455/560
*	G	US-2002/0119788 A1	08-2002	Parupudi et al.	455/456
*	Η	US-6,597,895 B1	07-2003	Maeda, Koji	455/88
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.